

2.55V/0.4A 1.8V/0.3A Output 2ch Synchronous Buck Converter Integrated FET



BD91501MUV

●Description

ROHM's buck converter BD91501MUV is a 2ch output power supply designed to produce a low voltage including 2.55V/0.4A and 1.8V/0.3A from 3.3V power supply line. Offers high efficiency with our original pulse skip control technology and synchronous rectifier. Employs a current mode control system to provide faster transient response to sudden change in load.

●Features

- Offers fast transient response with current mode PWM control system.
- Offers highly efficiency for all load range with synchronous rectifier (Pch/Nch FET) and SLLM™ (Simple Light Load Mode)
- Incorporates soft start function
- Incorporates thermal protection and UVLO function
- Incorporates short-current protection with timer latch
- Incorporates shutdown function $I_{cc}=0\mu A$ (Typ.)
- Full 100% Duty function
- 2ch output power supply (2.55V, 1.8V)
- 2ch output ON/OFF individual control
- Employs small surface mount package: VQFN016V3030

●Usage

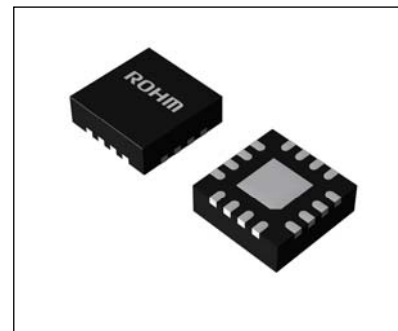
Power supply for LSI including DSP, DDR(RAM), Micro computer and ASIC

●Key Specifications

■ Input voltage range:	2.55V to 5.5V
■ Output volatage:	1.8V, 2.55V
■ Output voltage accuracy	±1.5%
■ Switching frequency:	1.65MHz±20%
■ Low Voltage Detection:	50%(Typ.)
■ Maximum on duty:	100%
■ Operating temperature range:	-30°C to +105°C

●Package

	(Typ.)	(Typ.)	(Max.)
VQFN016V3030:	3.00mm	× 3.00	× 1.00mm



VQFN016V3030

●Typical Application Circuit

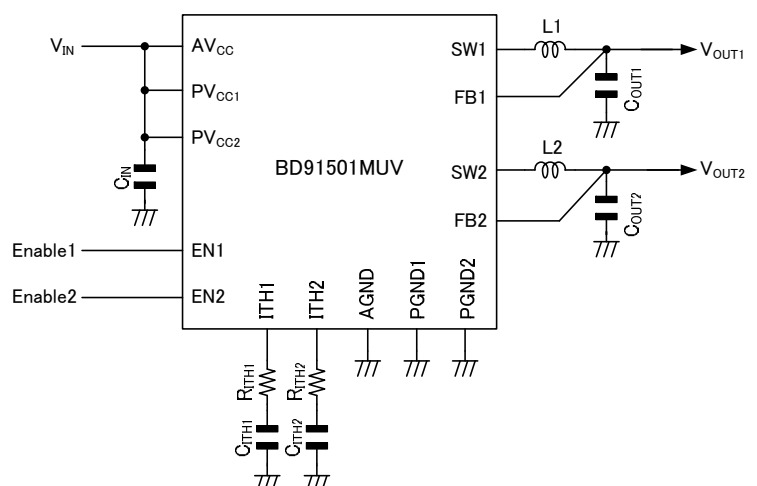


Figure.1 Typical Application Circuit

○Product structure : Silicon monolithic integrated circuit ○This product is not designed protection against radioactive rays.

●Pin Configuration(TOP VIEW)

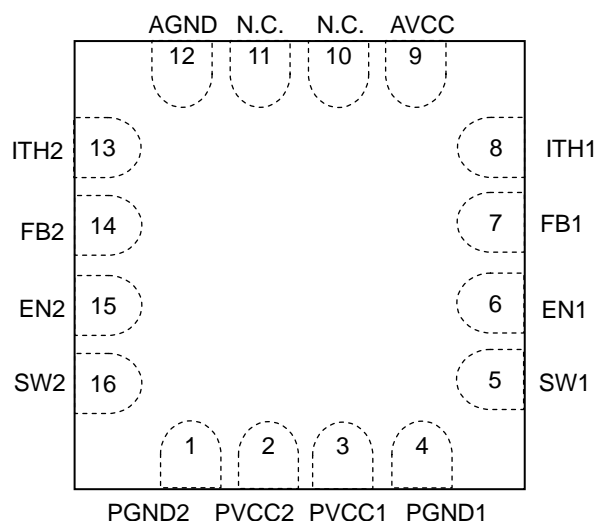


Figure.2 Pin ConFigureuration

●Pin Description

Pin No.	Pin name	Pin Function	Pin No.	Pin name	Pin Function
1	PGND2	Ch2 Low side source pin	9	AVCC	Analog VCC pin
2	PVcc2	Ch2 High side source pin	10	N.C.	Non connection (Please connect to AGND)
3	PVcc1	Ch1 High side source pin	11	N.C.	Non connection (Please connect to AGND)
4	PGND1	Ch1 Low side source pin	12	AGND	Analog GND pin
5	SW1	Ch1 Pch/Nch FET drain output pin	13	ITH2	Ch2 gm amplifier output pin /Connected phase compensation capacitor
6	EN1	Ch1 Enable pin (High Active)	14	FB2	Ch2 Output voltage detect pin
7	FB1	Ch1 Output voltage detect pin	15	EN2	Ch2 Enable pin (High Active)
8	ITH1	Ch1 gm amplifier output pin /Connected phase compensation capacitor	16	SW2	Ch2 Pch/Nch FET drain output pin

●Block Diagram

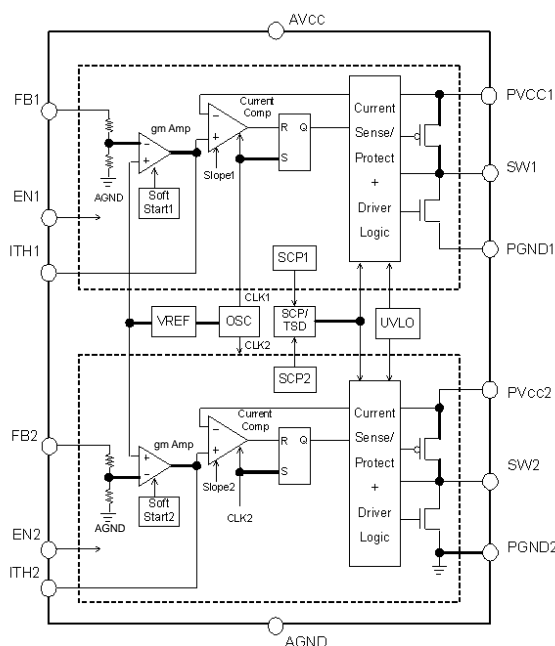


Figure.3 Block Diagram

●Absolute Maximum Ratings (Ta=25°C)

Parameter	Symbol	Rating	Unit
Power Supply Voltage	V _{CC}	-0.3 to +7 * ¹	V
EN Voltage	V _{EN1}	-0.3 to +7	V
	V _{EN2}	-0.3 to +7	V
SW Voltage	V _{sw1}	-0.3 to +7	V
	V _{sw2}	-0.3 to +7	V
Power Dissipation	P _{d1}	0.27 * ²	W
	P _{d2}	0.62 * ³	W
	P _{d3}	1.77 * ⁴	W
	P _{d4}	2.66 * ⁵	W
Operating temperature range	T _{opr}	-30 to +105	°C
Storage temperature range	T _{stg}	-55 to +150	°C
Maximum junction temperature	T _j	+150	°C

*¹ P_d, A_{SO} and T_j=150°C should not be exceeded.

*² IC only

*³ 1-layer. mounted on a 74.2mm × 74.2mm × 1.6mm Glass-epoxy PCB, (Copper foil area: Surface 6.28mm²)

*⁴ 4-layer. mounted on a 74.2mm × 74.2mm × 1.6mm Glass-epoxy PCB, (Copper foil area: Surface and bottom layer 6.28mm², 2nd and 3rd layer 5505mm²)

*⁵ 4-layer. mounted on a 74.2mm × 74.2mm × 1.6mm Glass-epoxy PCB, (Copper foil area: all layers 5505mm²)

●Recommended Operating Ratings (Ta=-30 to +105°C)

Parameter	Symbol	Limits			Unit
		Min.	Typ.	Max.	
Power Supply Voltage	A _{VCC}	2.55	3.3	5.5	V
	P _{VCC}	2.55	3.3	5.5	V
EN Voltage	V _{EN1}	0	-	A _{VCC}	V
	V _{EN2}	0	-	A _{VCC}	V
SW average output current	I _{sw1}	-	-	400* ⁶	mA
	I _{sw2}	-	-	300* ⁶	mA

*⁶ P_d and A_{SO} should not be exceeded.

●Electrical Characteristics (Ta=25°C AVCC=PVCC=3.3V, EN1=EN2=AVCC, unless otherwise specified.)

Parameter	Symbol	Limits			Unit	Conditions
		Min.	Typ.	Max.		
Standby Current	I _{STB}	-	0	10	μA	EN1=EN2=0V
Bias Current	I _{CC}	-	500	800	μA	
EN Low Voltage	V _{ENL}	-	GND	0.8	V	In stand-by mode
EN High Voltage	V _{ENH}	2.0	V _{CC}	-	V	In active mode
EN Input Current	I _{EN}	-	1	10	μA	V _{EN1} =V _{EN2} =2V
Oscillation Frequency	F _{OSC}	1.32	1.65	1.98	MHz	
Pch FET ON Resistor	R _{ONP1}	-	0.85	1.56	Ω	V _{CC} =3.3V
	R _{ONP2}	-	0.85	1.56	Ω	V _{CC} =3.3V
Nch FET ON Resistor	R _{ONN1}	-	0.65	1.3	Ω	V _{CC} =3.3V
	R _{ONN2}	-	0.65	1.3	Ω	V _{CC} =3.3V
Output Voltage	FB1	2.512	2.55	2.588	V	±1.5%
	FB2	1.773	1.8	1.827	V	±1.5%
UVLO Threshold Voltage	V _{UVLO1}	2.20	2.30	2.40	V	V _{CC} =5V→0V
UVLO Release Voltage	V _{UVLO2}	2.22	2.35	2.50	V	V _{CC} =0V→5V
Soft Start Time	T _{SS}	0.45	0.9	1.8	ms	
Timer Latch Time	T _{LATCH}	0.62	1.24	2.48	ms	SCP/TSD ON
Output Short circuit Threshold Voltage	V _{SCP1}	-	1.275	1.77	V	FB1=2.55→0V
	V _{SCP2}	-	0.9	1.26	V	FB2=1.8→0V

●Characteristics data (Reference data)

(Ta=25°C, VCC=3.3V, VEN=3.3V, Unless Otherwise specified)

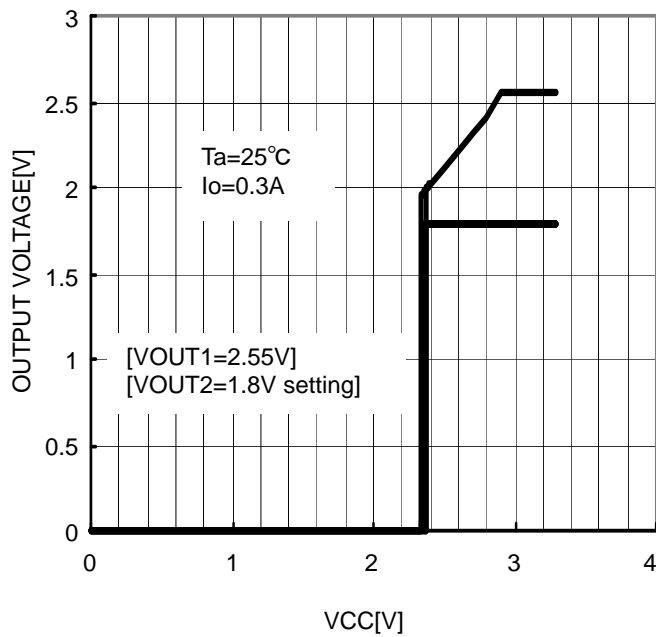


Figure.4 VCC-VOUT

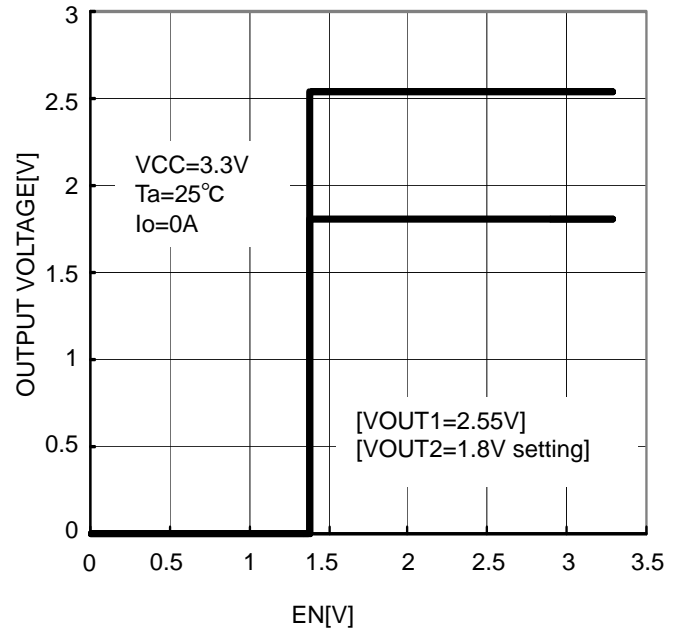


Figure.5 VEN-VOUT

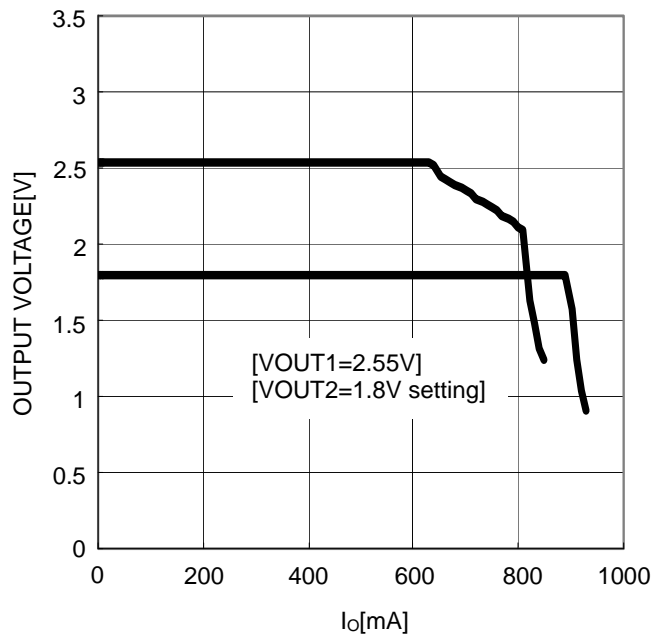


Figure.6 IOU-VOUT

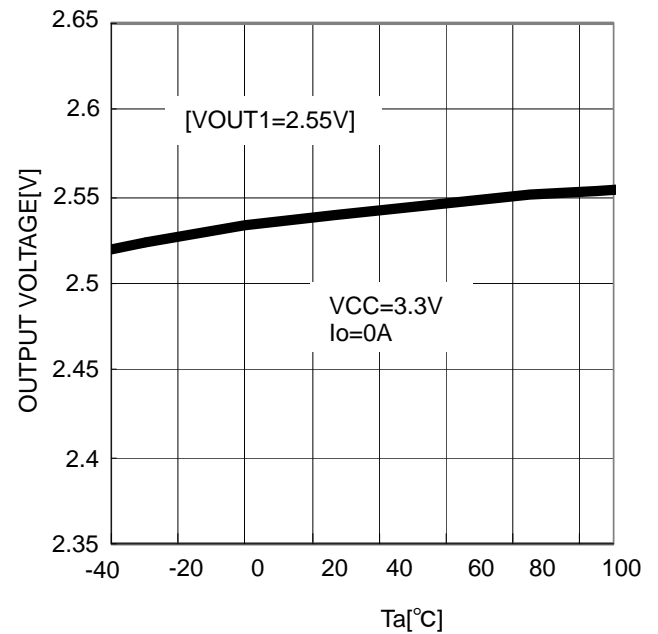


Figure.7 Ta-VOUT1

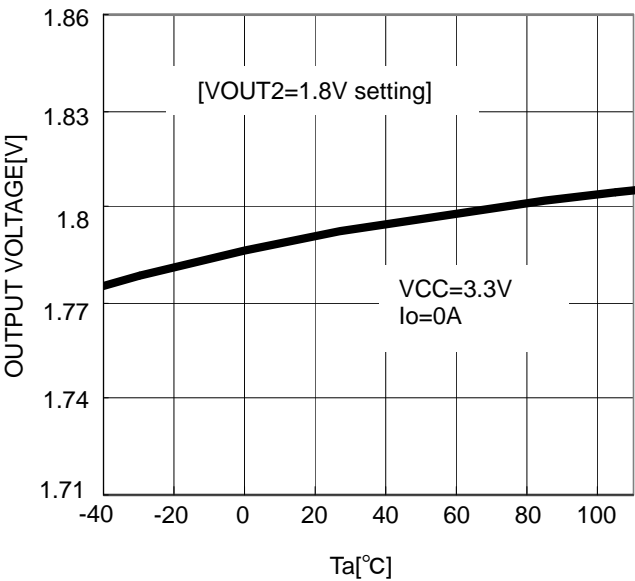


Figure.8 Ta-VOUT2

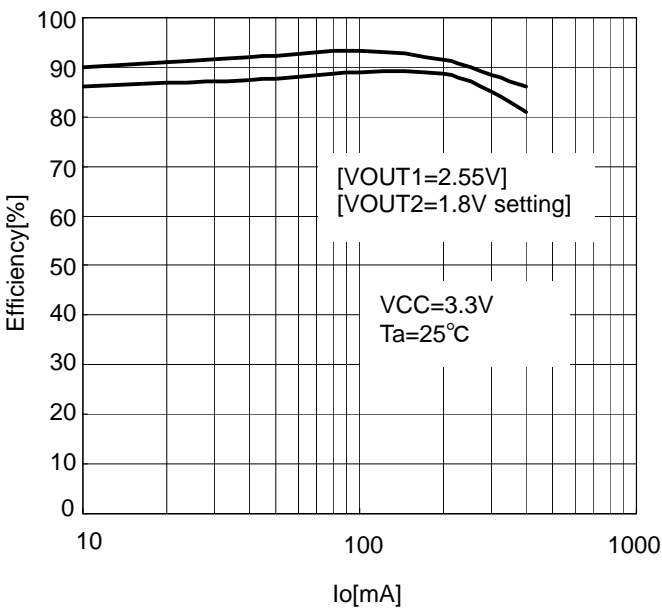


Figure.9 Efficiency

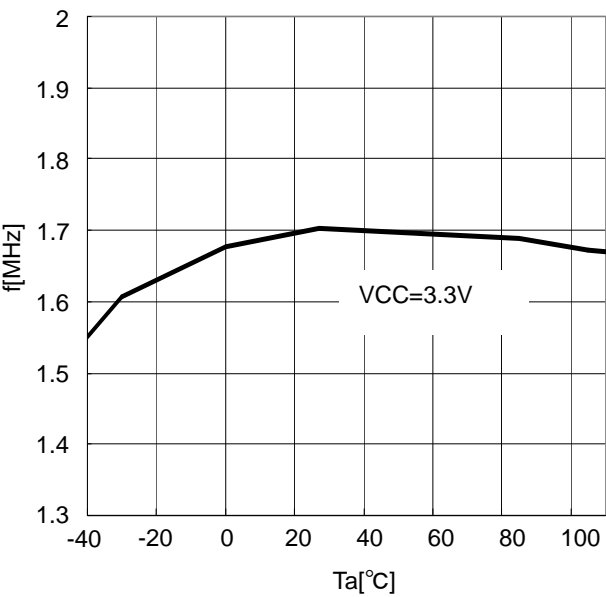


Figure.10 Ta-Fosc

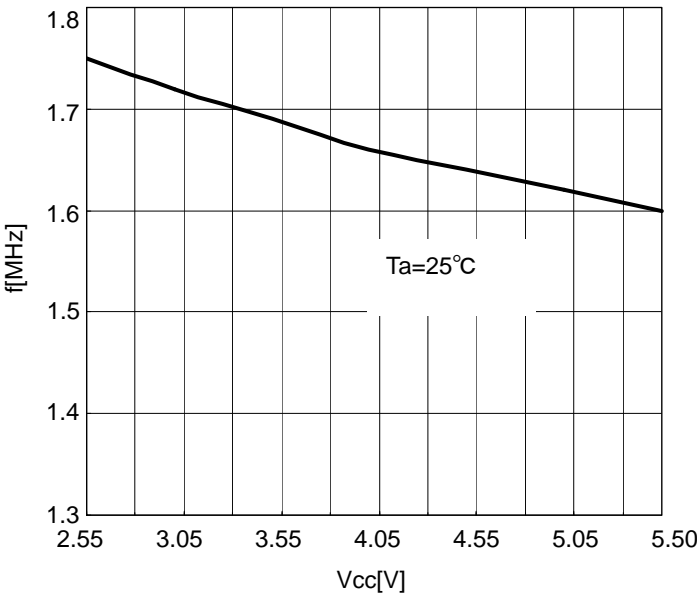


Figure.11 VCC-Fosc

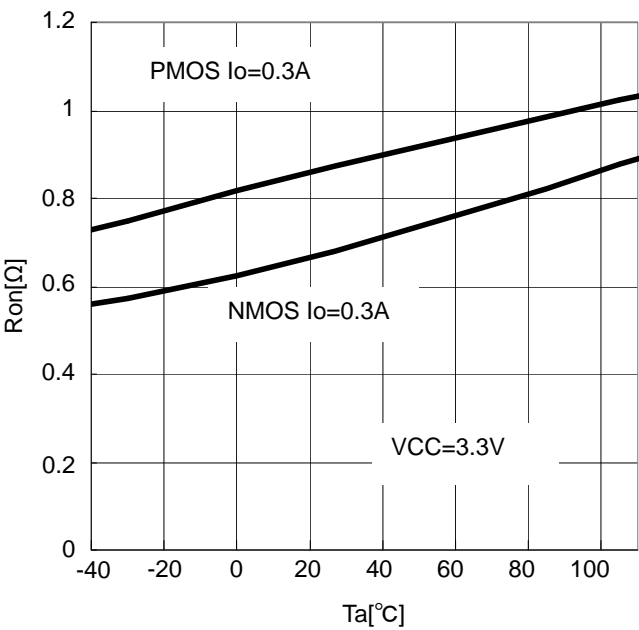


Figure.12 T_a - R_{ONN} , R_{ONP}

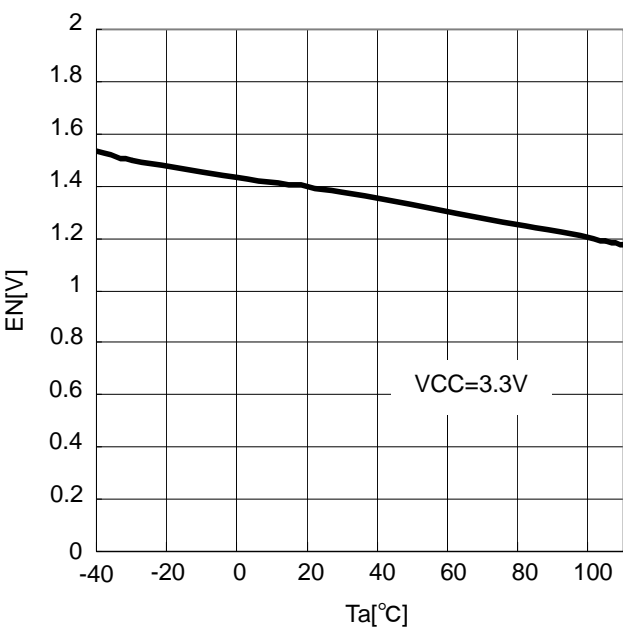


Figure.13 T_a - V_{EN1} , V_{EN2}

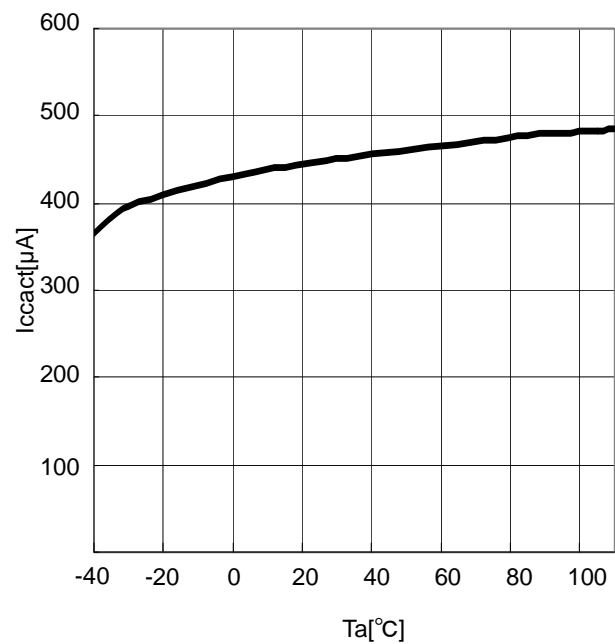


Figure.14 T_a - I_{CC}

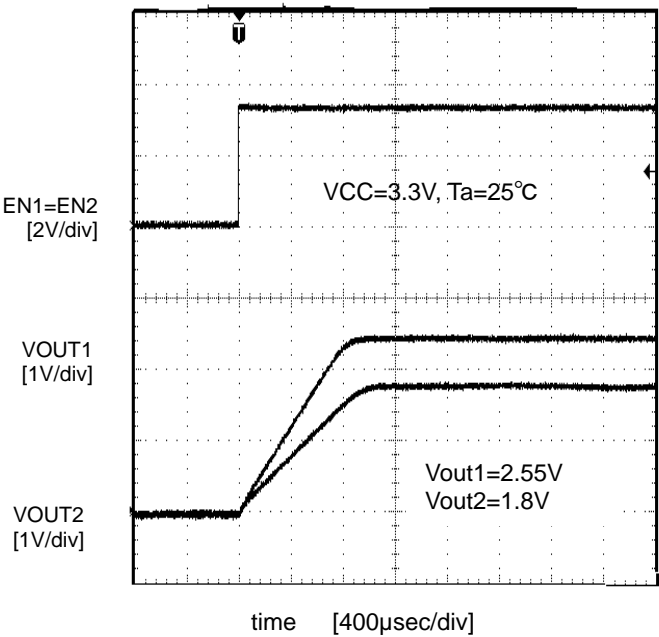


Figure.15 Soft start waveform
($I_o=0mA$)

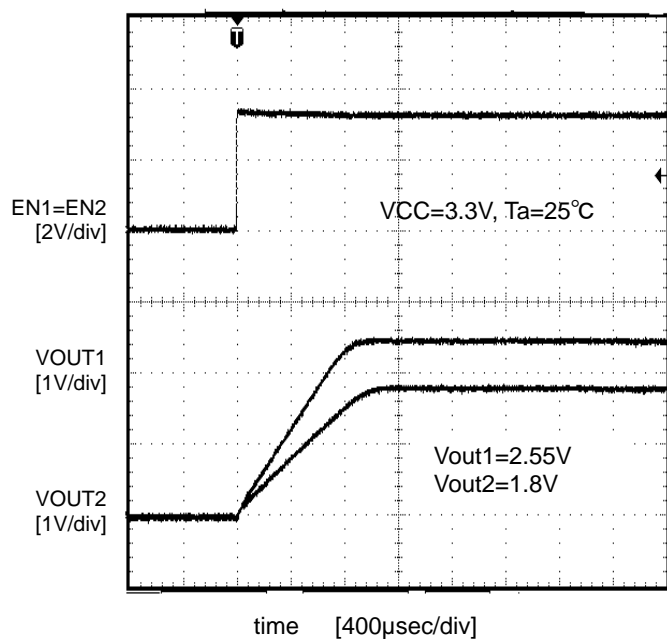


Figure.16 Soft start waveform
(Io=0.3A)

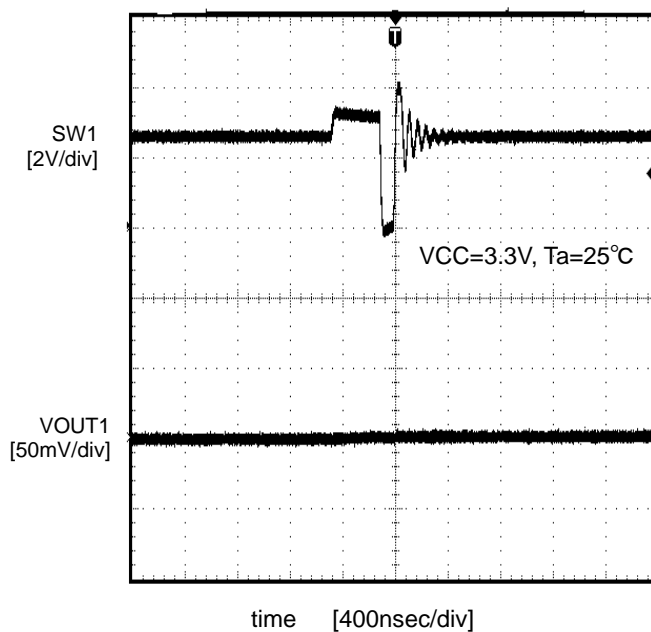


Figure.17 SW waveform 1
(Io=0mA)

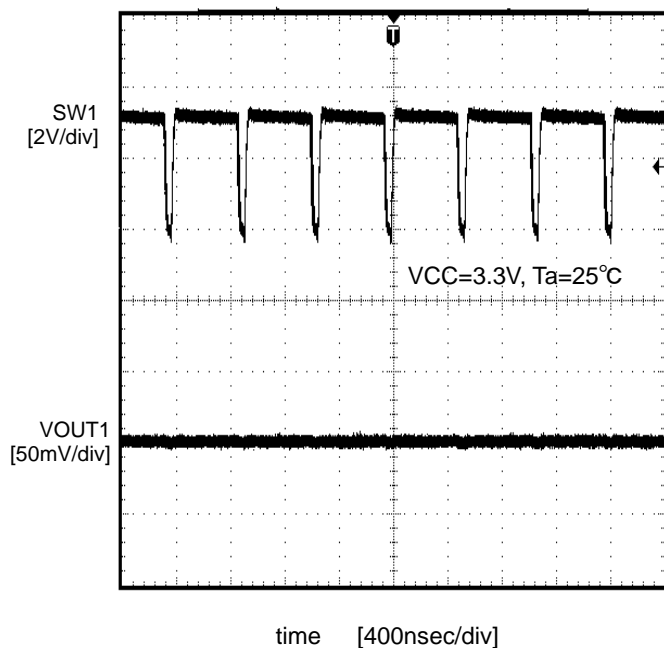


Figure.18 SW waveform 1
(Io=0.25A)

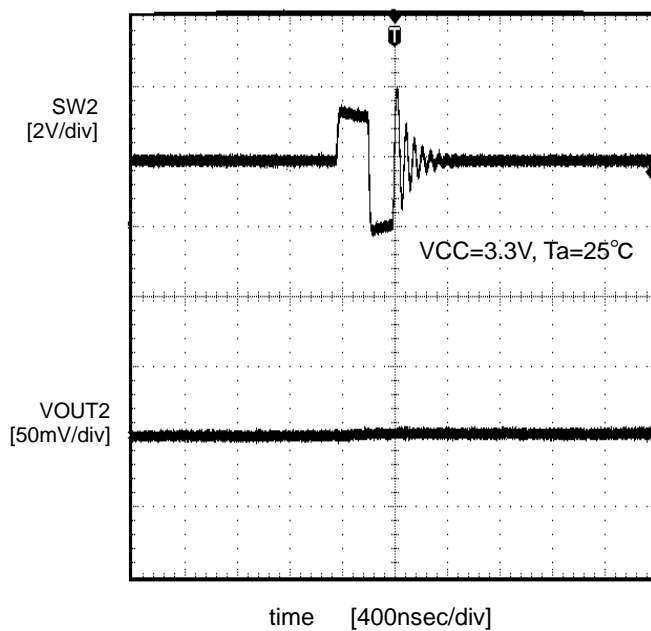


Figure.19 SW waveform 2
(Io=0mA)

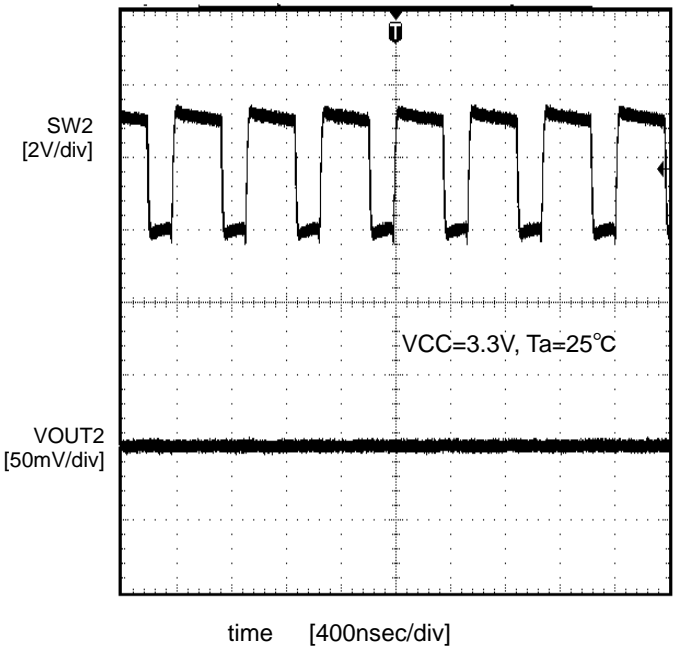


Figure.20 SW waveform 2
(Io=0.25A)

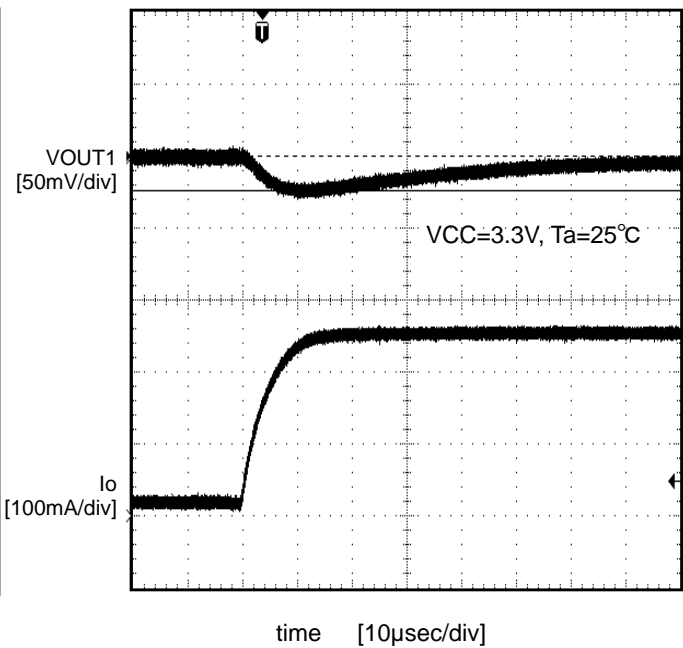


Figure.21 VOUT1 Transient response
(Io=10mA→0.25A)

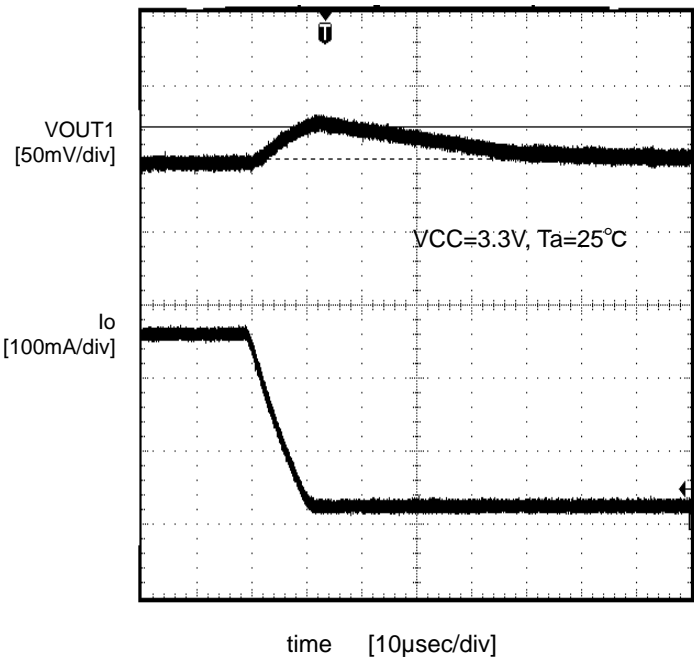


Figure.22 VOUT1 Transient response
(Io=0.25A→10mA)

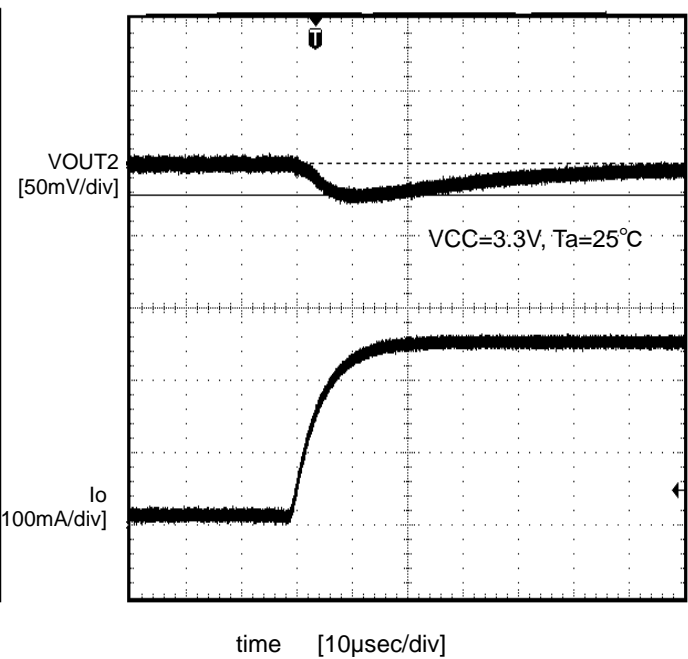


Figure.23 VOUT2 Transient response
(Io=10mA→0.25A)

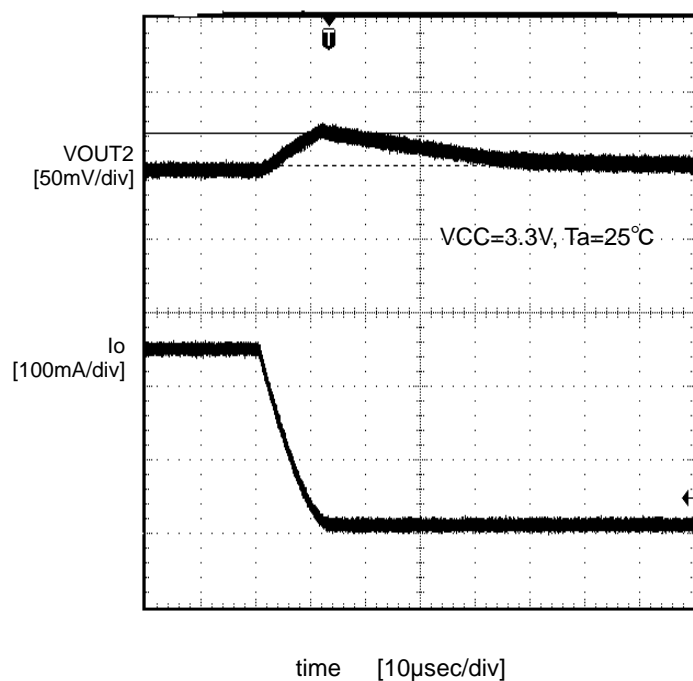


Figure.24 VOUT2 Transient response
($I_o=0.25\text{A}\rightarrow 10\text{mA}$)

●Operation

BD91501MUV is a synchronous Buck Converter that achieves faster transient response by employing current mode PWM control system. It utilizes switching operation in PWM (Pulse Width Modulation) mode for heavier load, while it utilizes SLLMTM (Simple Light Load Mode) operation for lighter load to improve efficiency.

○Synchronous rectifier

It does not require the power to be dissipated by a rectifier externally connected to a conventional DC/DC converter IC, and its P.N junction shoot-through protection circuit limits the shoot-through current during operation, by which the power dissipation of the set is reduced.

○Current mode PWM control

Synthesizes a PWM control signal with the inductor current feedback loop added to the voltage feedback. Offers fast transient response with current mode control system. Improves output voltage drop of load rapid change.

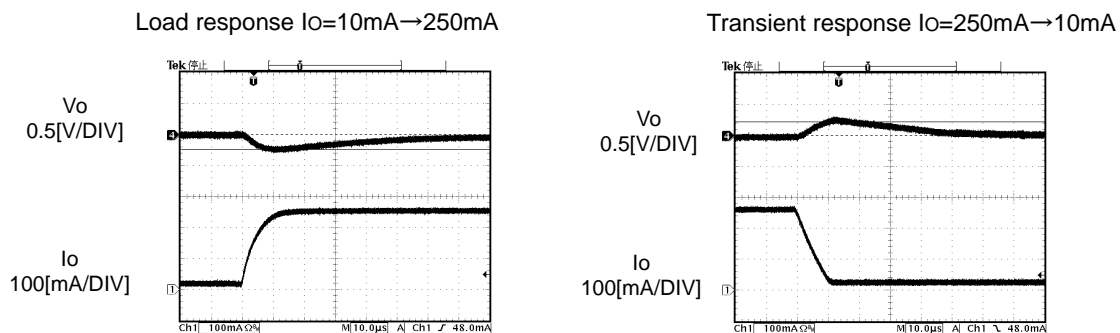


Figure.25 Transient response

• PWM (Pulse Width Modulation) control

The oscillation frequency for PWM is 1.65 MHz. SET signal from OSC turns ON a highside MOS FET (while a lowside MOS FET is turned OFF), and an inductor current I_L increases. The current comparator (Current Comp) receives two signals, a current feedback control signal (SENSE: Voltage converted from I_L) and a voltage feedback control signal (FB), and issues a RESET signal if both input signals are identical to each other, and turns OFF the highside MOS FET (while a lowside MOS FET is turned ON) for the rest of the fixed period. The PWM control repeat this operation.

• SLLMTM (Simple Light Load Mode) control

When the control mode is shifted from PWM for heavier load to the one for lighter load or vice versa, the switching pulse is designed to turn OFF with the device held operated in normal PWM control loop, which allows linear operation without voltage drop or deterioration in transient response during the mode switching from light load to heavy load or vice versa.

Although the PWM control loop continues to operate with a SET signal from OSC and a RESET signal from Current Comp, it is so designed that the RESET signal is held issued if shifted to the light load mode, with which the switching is tuned OFF and the switching pulses are thinned out under control. Activating the switching intermittently reduces the switching dissipation and improves the efficiency.

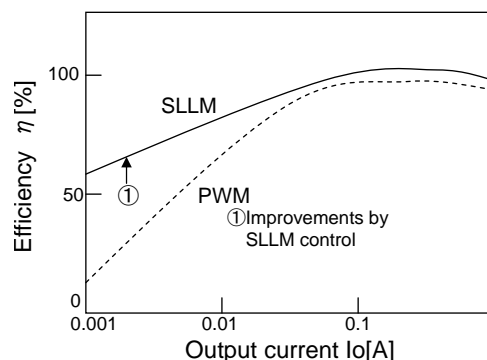


Figure.26 Efficiency characteristics

- 100% Duty control

Maximum Duty is 100% (Pch MOSFET is always ON). If output voltage cannot keep steady because of input voltage drop for normal PWM control, oscillation frequency gets low, and becomes 100% Duty finally. Output voltage value is the dropped value of Pch MOSFET's ON voltage so that even low input voltage can keep output voltage.

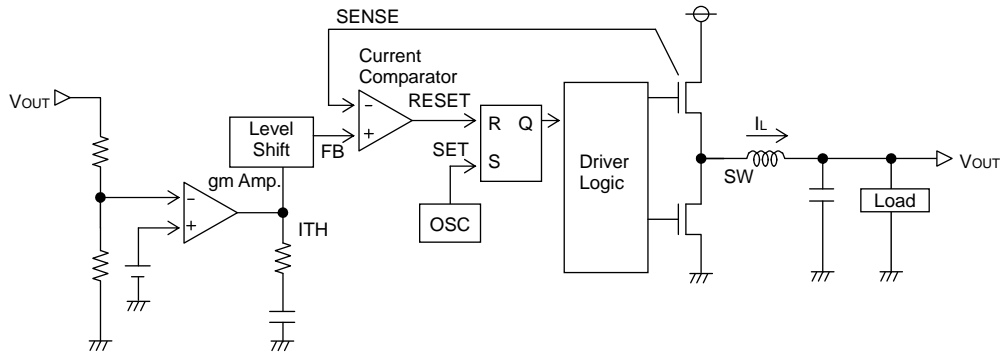


Figure.27 Current mode PWM control block diagram

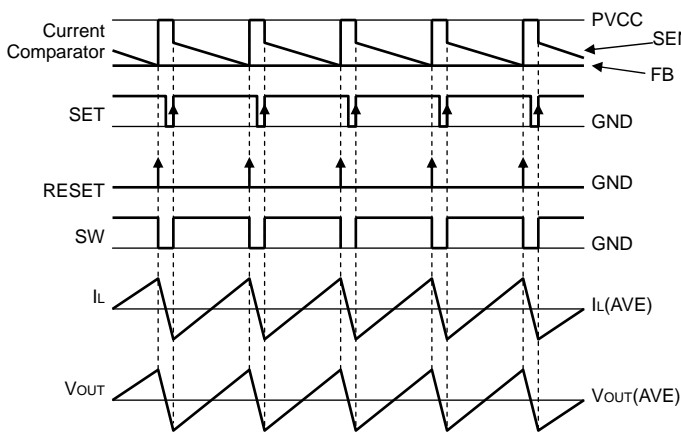


Figure.28 PWM Switching timing chart

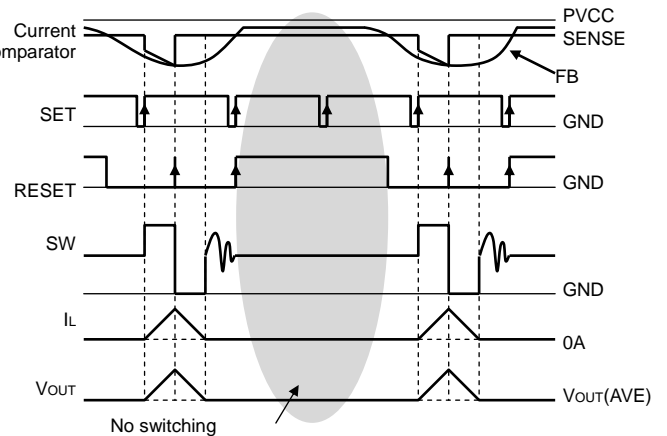


Figure.29 SLLM™ Switching timing chart

- Soft-start function

EN terminal shifted to “High” activates a soft-starter to gradually establish the output voltage with the current limited during startup, by which it is possible to prevent an overshoot of output voltage and an inrush current.

- Shutdown function

With EN terminal shifted to “Low”, the device turns to Standby Mode, and all the function blocks including reference voltage circuit, internal oscillator and drivers are turned to OFF. Circuit current during standby is $0\mu\text{A}$ (Typ.).

- UVLO function

Detects whether the input voltage sufficient to secure the output voltage of this IC is supplied. And the hysteresis width of 50mV (Typ.) is provided to prevent output chattering.

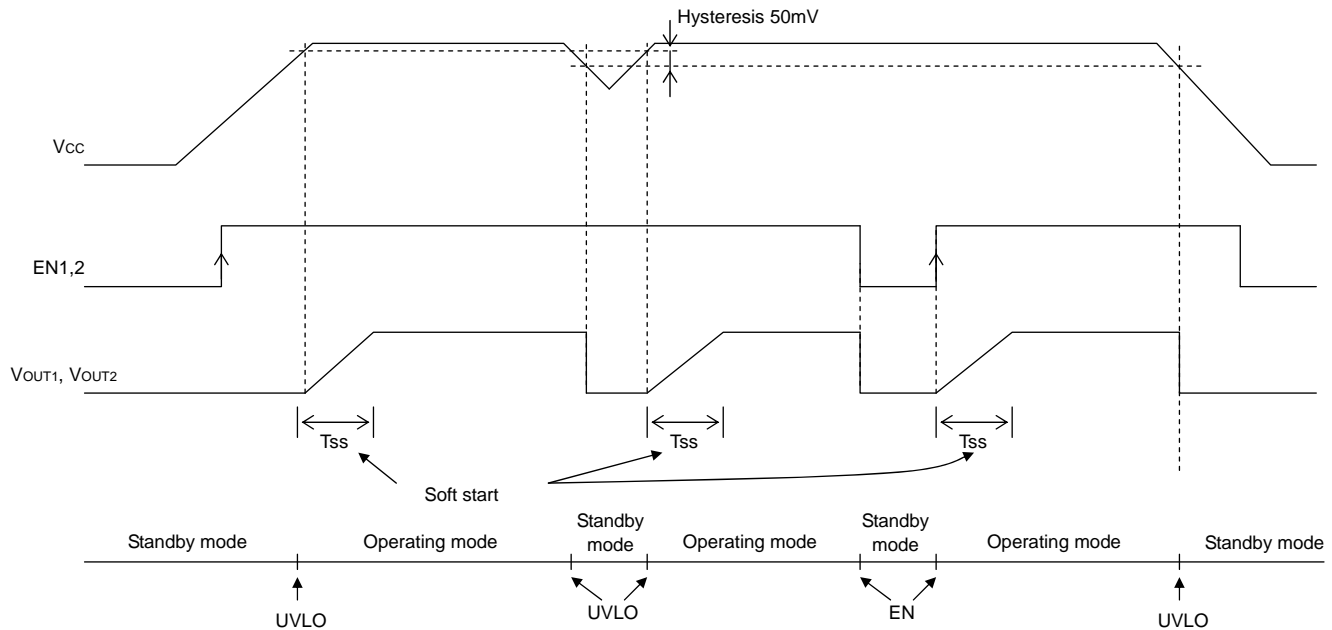


Figure.30 Soft start, Shut down, UVLO Timing chart

- Short-current protection circuit with time delay function

Turns OFF the output to protect the IC from breakdown when the incorporated current limiter is activated continuously for the fixed time (T_{LATCH}) or more. The output thus held tuned OFF may be recovered by restarting EN or by re-unlocking UVLO.

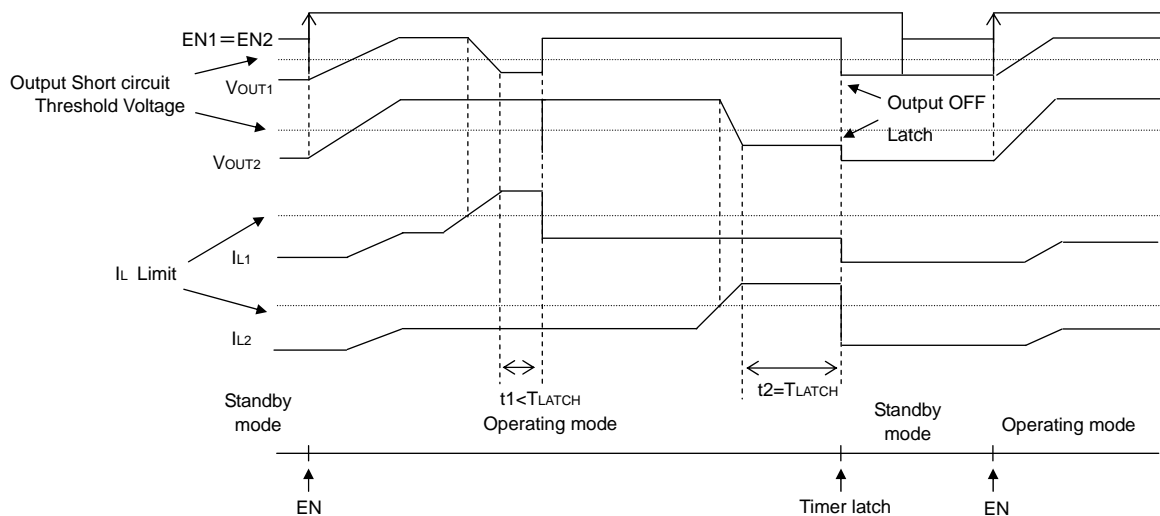


Figure.31 Soft start, Shut down, UVLO Timing chart

● Switching regulator efficiency

Efficiency η may be expressed by the equation shown below:

$$\eta = \frac{V_{OUT} \times I_{OUT}}{V_{in} \times I_{in}} \times 100[\%] = \frac{P_{OUT}}{P_{in}} \times 100[\%] = \frac{P_{OUT}}{P_{OUT} + P_{D\alpha}} \times 100[\%]$$

Efficiency may be improved by reducing the switching regulator power dissipation factors $P_{D\alpha}$ as follows:

Dissipation factors:

- 1) ON resistance dissipation of inductor and FET : $P_D(I^2R)$
- 2) Gate charge/discharge dissipation : $P_D(\text{Gate})$
- 3) Switching dissipation : $P_D(\text{SW})$
- 4) ESR dissipation of capacitor : $P_D(\text{ESR})$
- 5) Operating current dissipation of IC : $P_D(\text{IC})$

1) $P_D(I^2R) = I_{OUT}^2 \times (R_{COIL} + R_{ON})$ ($R_{COIL}[\Omega]$: DC resistance of inductor, $R_{ON}[\Omega]$: ON resistance of FET, $I_{OUT}[A]$: Output current.)

2) $P_D(\text{Gate}) = C_{gs} \times f \times V$ ($C_{gs}[F]$: Gate capacitance of FET, $f[H]$: Switching frequency, $V[V]$: Gate driving voltage of FET)

3) $P_D(\text{SW}) = \frac{V_{in}^2 \times C_{RSS} \times I_{OUT} \times f}{I_{DRIVE}}$ ($C_{RSS}[F]$: Reverse transfer capacitance of FET, $I_{DRIVE}[A]$: Peak current of gate.)

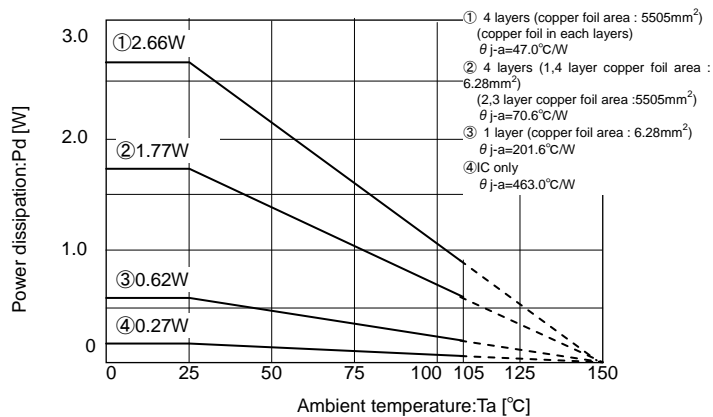
4) $P_D(\text{ESR}) = I_{RMS}^2 \times ESR$ ($I_{RMS}[A]$: Ripple current of capacitor, $ESR[\Omega]$: Equivalent series resistance.)

5) $P_D(\text{IC}) = V_{in} \times I_{CC}$ ($I_{CC}[A]$: Circuit current.)

● Consideration on permissible dissipation and heat generation

As this IC functions with high efficiency without significant heat generation in most applications, no special consideration is needed on permissible dissipation or heat generation. In case of extreme conditions, however, including lower input voltage, higher output voltage, heavier load, and/or higher temperature, the permissible dissipation and/or heat generation must be carefully considered.

For dissipation, only conduction losses due to DC resistance of inductor and ON resistance of FET are considered. Because the conduction losses are considered to play the leading role among other dissipation mentioned above including gate charge/discharge dissipation and switching dissipation.



$$P = I_{OUT}^2 \times R_{ON}$$

$$R_{ON} = D \times R_{ONH} + (1-D)R_{ONL}$$

$$D : \text{ON Duty} (= V_{OUT}/V_{CC})$$

R_{ONH} : Highside MOS FET impedance

R_{ONL} : Lowside MOS FET impedance

I_{OUT} : Output current

Figure.32 Thermal derating curve (VQFN016-V3030)

Example) If $V_{CC}=3.3V$, $V_{OUT1}=2.55V$, $V_{OUT2}=1.8V$, $R_{ONH}=850m\Omega$, $R_{ONL}=650m\Omega$, $I_{OUT}=300mA$

$$D_1 = V_{OUT1}/V_{CC} = 2.55/3.3 = 0.77$$

$$D_2 = V_{OUT2}/V_{CC} = 1.8/3.3 = 0.55$$

$$R_{ON1} = 0.77 \times 0.85 + (1-0.77) \times 0.65$$

$$= 0.804 [\Omega]$$

$$R_{ON2} = 0.55 \times 0.85 + (1-0.55) \times 0.65$$

$$= 0.760 [\Omega]$$

$$P = 0.3^2 \times 0.804 + 0.3^2 \times 0.760 = 0.141 [W]$$

As R_{ONH} is greater than R_{ONL} in this IC, the dissipation increases as the ON duty becomes greater. With the consideration on the dissipation as above, thermal design must be carried out with sufficient margin allowed.

● Selection of components externally connected

1. Selection of inductor (L)

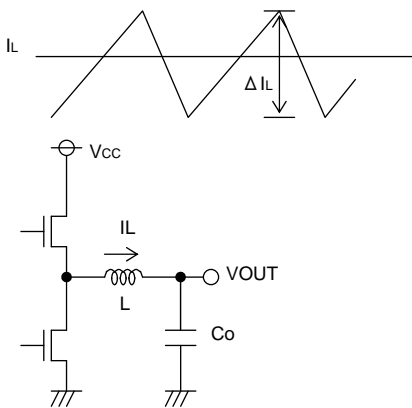


Figure.33 Output ripple current

Ripple current value at output is greatly influenced by inductor value. Refer to equation of (1), Ripple current value is more decrease at switching frequency is higher and at inductor value is larger.

$$\Delta I_L = \frac{(V_{CC} - V_{OUT}) \times V_{OUT}}{L \times V_{CC} \times f} \quad [A] \quad \cdot \cdot \cdot (1)$$

Appropriate ripple current at output should be 60% more or less of the maximum output current

$$\Delta I_L = 0.6 \times I_{OUTmax.} \quad [A] \quad \cdot \cdot \cdot (2)$$

$$L = \frac{(V_{CC} - V_{OUT}) \times V_{OUT}}{\Delta I_L \times V_{CC} \times f} \quad [H] \quad \cdot \cdot \cdot (3)$$

(ΔI_L : Output ripple current, f : Switching frequency)

Output ripple current turns to be cramped at about 0.9A peak by considering the stable start-up.

※Current exceeding the current rating of the inductor results in magnetic saturation of the inductor, which decreases efficiency. The inductor must be selected allowing sufficient margin with which the peak current may not exceed its current rating.

Example) for BD91501MUV, if $V_{CC}=3.3V$, $V_{OUT}=2.55V$, $f=1.65MHz$, $\Delta I_L=0.6 \times 0.3A=0.18A$

$$L = \frac{(3.3-2.55) \times 2.55}{0.18 \times 3.3 \times 1650K} = 1.95\mu H \quad \rightarrow 1.5\mu H \sim 4.7\mu H$$

※Select the inductor of low resistance component (such as DCR and ACR) to minimize dissipation in the inductor for better efficiency.

2. Selection of output capacitor (Co)

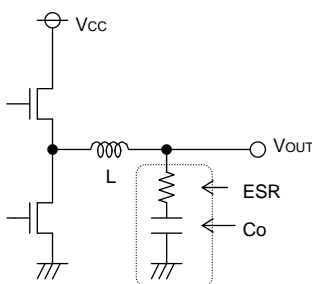


Figure.34 Output capacitor

Output capacitor should be selected with the consideration on the stability region and the equivalent series resistance required to smooth ripple voltage.

Output ripple voltage is determined by the equation (4) :

$$\Delta V_{OUT} = \Delta I_L \times ESR \quad [V] \quad \cdot \cdot \cdot (4)$$

(ΔI_L : Output ripple current, ESR: Equivalent series resistance of output capacitor)

※Rating of the capacitor should be determined allowing sufficient margin against output voltage. 22 μF to 100 μF ceramic capacitor is recommended. Less ESR allows reduction in output ripple voltage.

3. Selection of input capacitor (Cin)

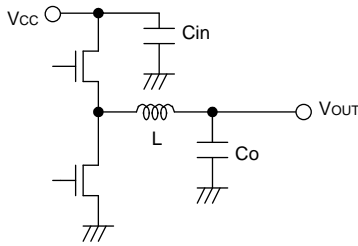


Figure.35 Input capacitor

Input capacitor to select must be a low ESR capacitor of the capacitance sufficient to cope with high ripple current to prevent high transient voltage. The ripple current I_{RMS} is given by the equation (5):

$$I_{RMS} = I_{OUT} \times \frac{\sqrt{V_{OUT}(V_{CC} - V_{OUT})}}{V_{CC}} \quad [A] \quad \dots (5)$$

< Worst case > $I_{RMS(max.)}$

$$\text{When } V_{CC} = 2 \times V_{OUT} \quad I_{RMS} = \frac{I_{OUT}}{2}$$

Example) for BD91501MUV, if $V_{CC} = 3.3V$, $V_{OUT} = 2.55V$, $I_{OUTmax.} = 0.3A$,

$$0.3 \times \frac{\sqrt{2.55(3.3 - 2.55)}}{3.3} = 0.126(A_{RMS})$$

A low ESR 22 μ F/10V ceramic capacitor is recommended to reduce ESR dissipation of input capacitor for better efficiency.

4. Determination of RITH, CITH that works as a phase compensator

As the Current Mode Control is designed to limit a inductor current, a pole (phase lag) appears in the low frequency area due to a CR filter consisting of a output capacitor and a load resistance, while a zero (phase lead) appears in the high frequency area due to the output capacitor and its ESR. So, the phases are easily compensated by adding a zero to the power amplifier output with C and R as described below to cancel a pole at the power amplifier.

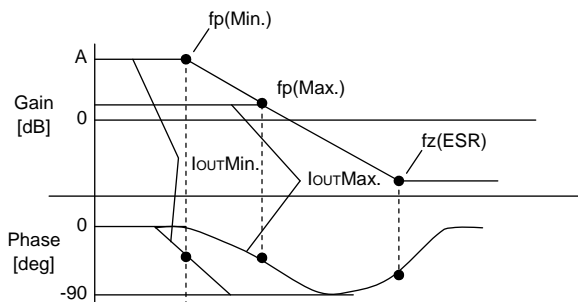


Figure.36 Open loop gain characteristics

$$f_p = \frac{1}{2\pi \times R_o \times C_o}$$

$$f_z(ESR) = \frac{1}{2\pi \times ESR \times C_o}$$

Pole at power amplifier

When the output current decreases, the load resistance R_o increases and the pole frequency lowers.

$$f_p(\text{Min.}) = \frac{1}{2\pi \times R_{O\text{Max.}} \times C_o} \quad [Hz] \leftarrow \text{with lighter load}$$

$$f_p(\text{Max.}) = \frac{1}{2\pi \times R_{O\text{Min.}} \times C_o} \quad [Hz] \leftarrow \text{with heavier load}$$

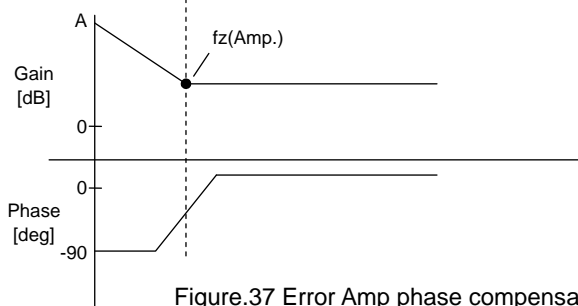


Figure.37 Error Amp phase compensation characteristics

Zero at power amplifier

Increasing capacitance of the output capacitor lowers the pole frequency while the zero frequency does not change. (This is because when the capacitance is doubled, the capacitor ESR reduces to half.)

$$f_z(\text{Amp.}) = \frac{1}{2\pi \times R_{ITH} \times C_{ITH}}$$

Stable feedback loop may be achieved by canceling the pole $f_p(\text{Min.})$ produced by the output capacitor and the load resistance with CR zero correction by the error amplifier.

$$f_z(\text{Amp.}) = f_p(\text{Min.})$$

$$\rightarrow \frac{1}{2\pi \times R_{ITH} \times C_{ITH}} = \frac{1}{2\pi \times R_{O\text{Max.}} \times C_o}$$

●Application Example

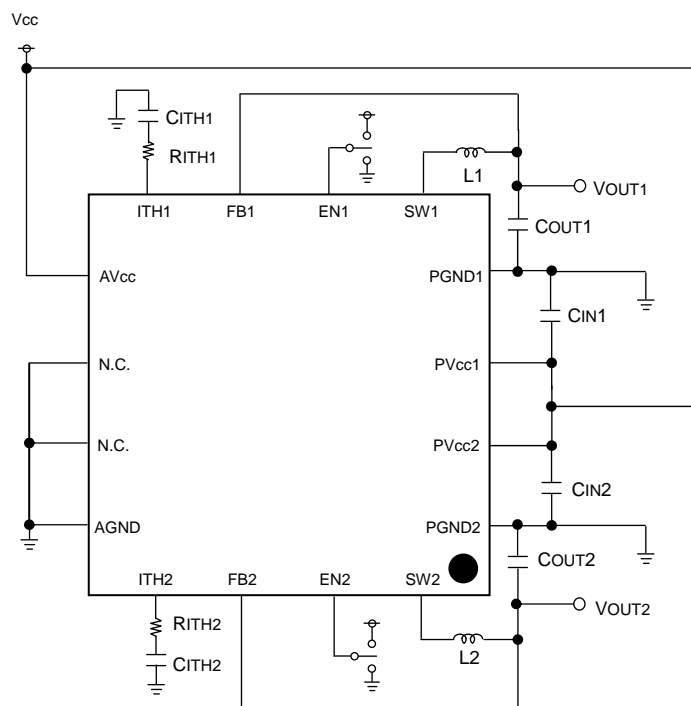


Figure.38 Application Example

●Evaluation

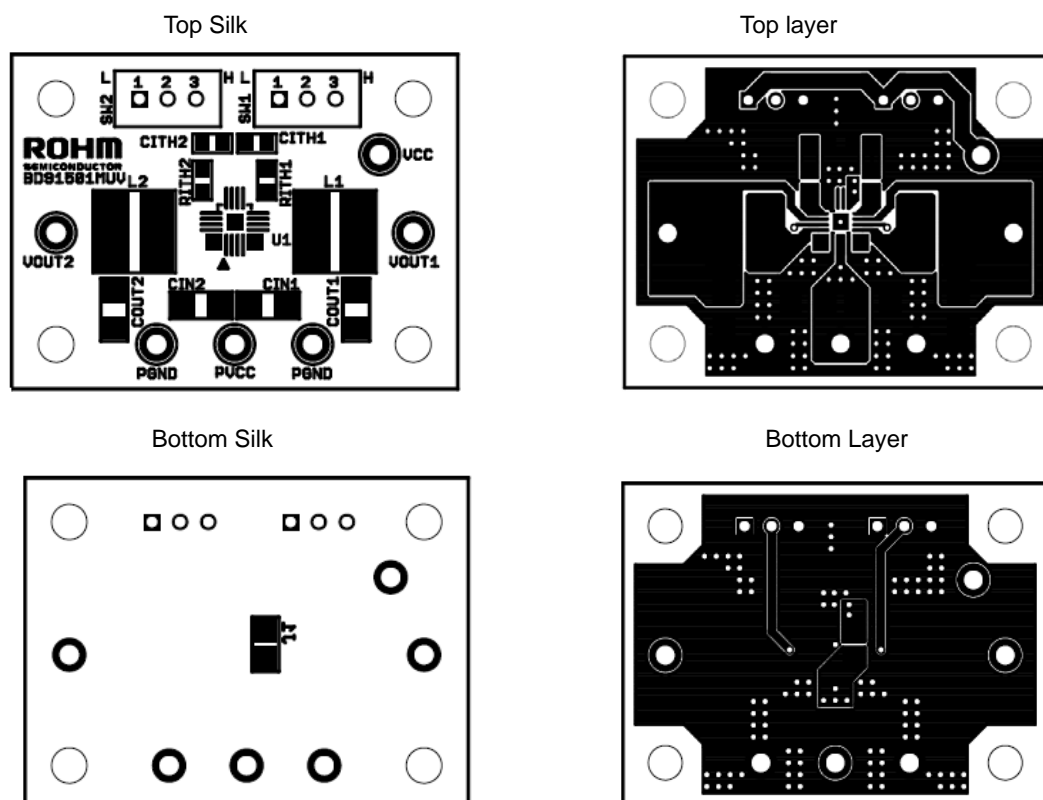


Figure.39 Layout Diagram

- ① Layout the input ceramic capacitor CIN closer to the pins PVCC and PGND, and the output capacitor Co closer to the pin PGND.
- ② Layout CITH and RITH between the pins ITH and GND as neat as possible with least necessary wiring.

※VQFN016V3030 (BD91501MUV) has thermal PAD on the reverse of the package.

The package thermal performance may be enhanced by bonding the PAD to GND plane which take a large area of PCB.

●Recommended components Lists on above application

Symbol	Type	Value	Manufacturer	Part Number
L1,2	Inductor	2.2μH	TOKO	DE2818C 1072AS-2R2M
CIN1,CIN2	Ceramic capacitor	22μF	Murata	GRM32EB11A226KE20
Cout1,Cout2	Ceramic capacitor	22μF	Murata	GRM31CB30J226KE18
CITH1	Ceramic capacitor	330pF	Murata	CRM18 Series
RITH1	Resistor	91kΩ	Rohm	MCR03 Series
CITH2	Ceramic capacitor	330pF	Murata	GRM18 Series
RITH2	Resistor	75kΩ	Rohm	MCR03 Series

※The parts list presented above is an example of recommended parts. Although the parts are sound, actual circuit characteristics should be checked on your application carefully before use. Be sure to allow sufficient margins to accommodate variations between external devices and this IC when employing the depicted circuit with other circuit constants modified. Both static and transient characteristics should be considered in establishing these margins. When switching noise is substantial and may impact the system, a low pass filter should be inserted between the VCC and PVCC pins, and a schottky barrier diode or snubber established between the SW and PGND pins.

● I/O equivalence circuit

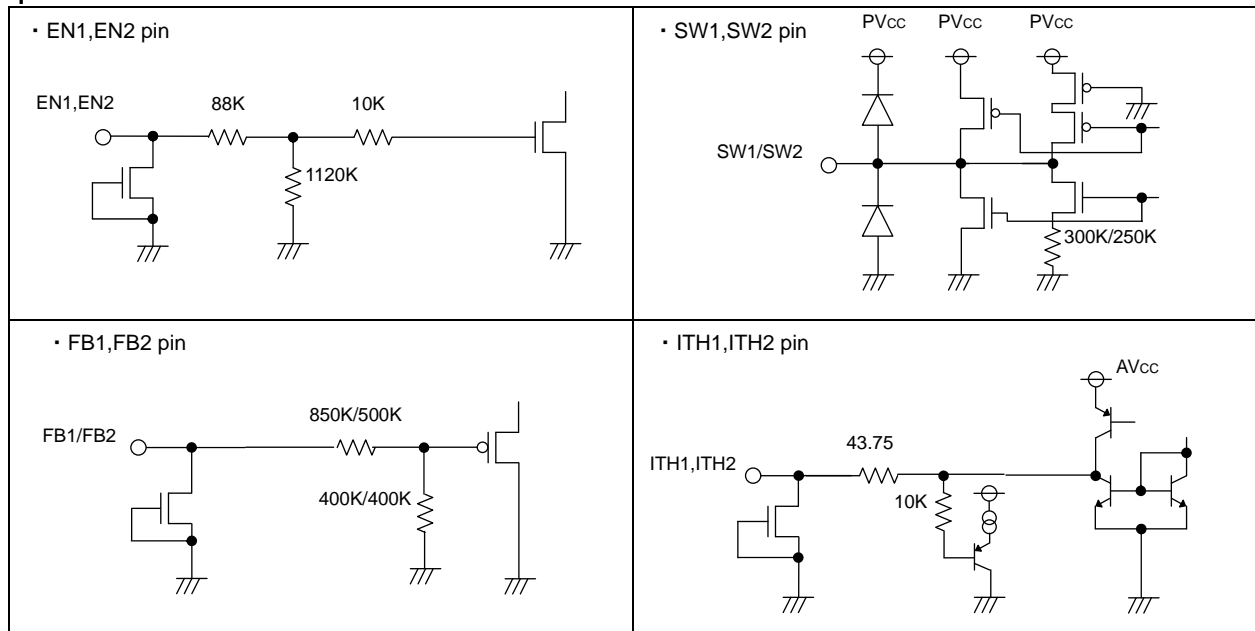


Figure.40 I/O equivalence circuit

● Operational Notes

1. Absolute Maximum Ratings

While utmost care is taken to quality control of this product, any application that may exceed some of the absolute maximum ratings including the voltage applied and the operating temperature range may result in breakage. If broken, short-mode or open-mode may not be identified. So if it is expected to encounter with special mode that may exceed the absolute maximum ratings, it is requested to take necessary safety measures physically including insertion of fuses.

2. Electrical potential at GND

GND must be designed to have the lowest electrical potential In any operating conditions.

3. Short-circuiting between terminals, and mismounting

When mounting to pc board, care must be taken to avoid mistake in its orientation and alignment. Failure to do so may result in IC breakdown. Short-circuiting due to foreign matters entered between output terminals, or between output and power supply or GND may also cause breakdown.

4. Thermal shutdown protection circuit

Thermal shutdown protection circuit is the circuit designed to isolate the IC from thermal runaway, and not intended to protect and guarantee the IC. So, the IC the thermal shutdown protection circuit of which is once activated should not be used thereafter for any operation originally intended.

5. Inspection with the IC set to a pc board

If a capacitor must be connected to the pin of lower impedance during inspection with the IC set to a pc board, the capacitor must be discharged after each process to avoid stress to the IC. For electrostatic protection, provide proper grounding to assembling processes with special care taken in handling and storage. When connecting to jigs in the inspection process, be sure to turn OFF the power supply before it is connected and removed.

6. Input to IC terminals

This is a monolithic IC with P⁺ isolation between P-substrate and each element as illustrated below. This P-layer and the N-layer of each element form a P-N junction, and various parasitic element are formed.

If a resistor is joined to a transistor terminal as shown in Figure 41.

OP-N junction works as a parasitic diode if the following relationship is satisfied; GND>Terminal A (at resistor side), or GND>Terminal B (at transistor side); and

Or if GND>Terminal B (at NPN transistor side),

a parasitic NPN transistor is activated by N-layer of other element adjacent to the above-mentioned parasitic diode.

The structure of the IC inevitably forms parasitic elements, the activation of which may cause interference among circuits, and/or malfunctions contributing to breakdown. It is therefore requested to take care not to use the device in such manner that the voltage lower than GND (at P-substrate) may be applied to the input terminal, which may result in activation of parasitic elements.

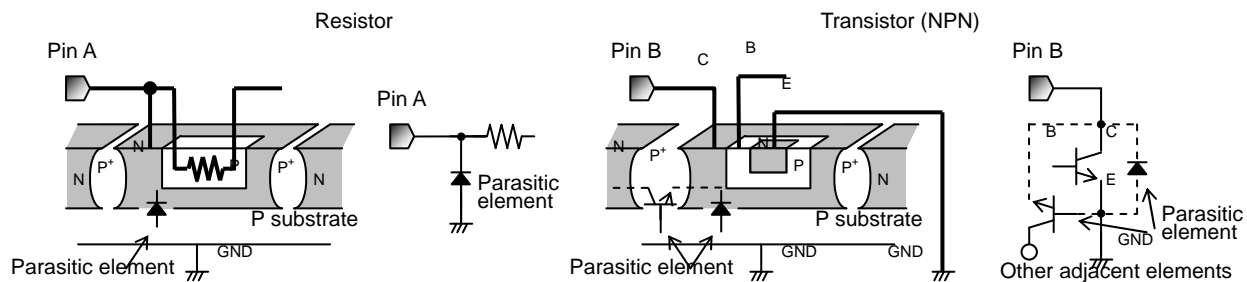


Figure.41 Simplified structure of monolithic IC

7. Ground wiring pattern

If small-signal GND and large-current GND are provided, It will be recommended to separate the large-current GND pattern from the small-signal GND pattern and establish a single ground at the reference point of the set PCB so that resistance to the wiring pattern and voltage fluctuations due to a large current will cause no fluctuations in voltages of the small-signal GND. Pay attention not to cause fluctuations in the GND wiring pattern of external parts as well.

8. Selection of inductor

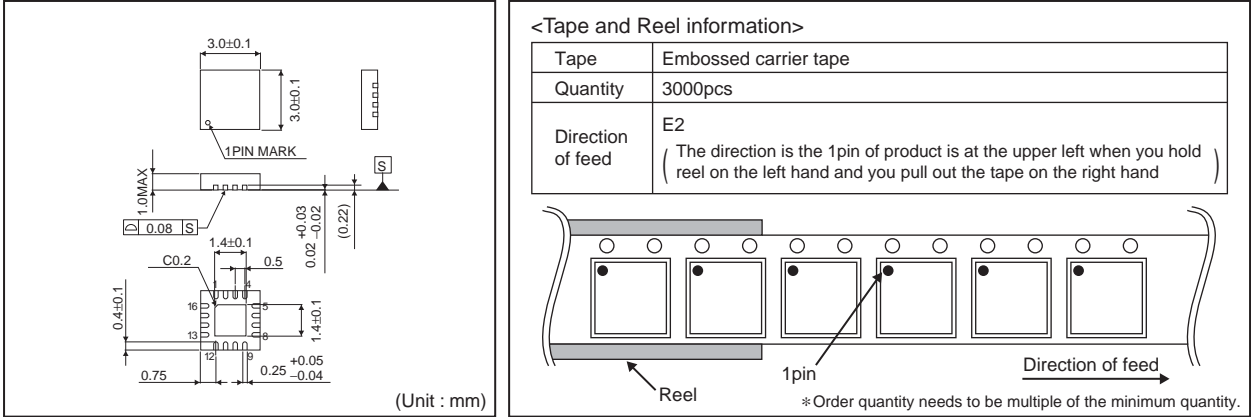
It is recommended to use an inductor with a series resistance element (DCR) 0.1 Ω or less. Especially, note that use of a high DCR inductor will cause an inductor loss, resulting in decreased output voltage. Should this condition continue for a specified period (soft start time + timer latch time), output short circuit protection will be activated and output will be latched OFF. When using an inductor over 0.1 Ω, be careful to ensure adequate margins for variation between external devices and this IC, including transient as well as static characteristics. Furthermore, in any case, it is recommended to start up the output with EN after supply voltage is within operation range.

●Ordering Information

B D 9 1 5 0 1 M U V	—	E 2
Part Number	Package MUV : VQFN016V3030	Packaging and forming specification E2 : Embossed taping and reel

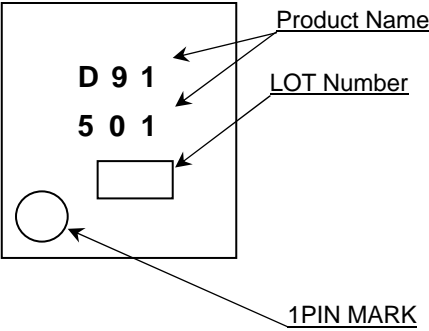
●Physical Dimension Tape and Reel Information

VQFN016V3030



●Marking Diagram (TOP VIEW)

VQFN016V3030



●Revision History

Date	Revision	Changes
31.Aug.2012	001	New Release

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JAPAN	USA	EU	CHINA
CLASS III	CLASS III	CLASS II b	CLASS III
CLASS IV		CLASS III	

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 - Use of our Products outdoors or in places where the Products are exposed to direct sunlight or dust
 - Use of our Products in places where the Products are exposed to sea wind or corrosive gases, including Cl₂, H₂S, NH₃, SO₂, and NO₂
 - Use of our Products in places where the Products are exposed to static electricity or electromagnetic waves
 - Use of our Products in proximity to heat-producing components, plastic cords, or other flammable items
 - Sealing or coating our Products with resin or other coating materials
 - Use of our Products without cleaning residue of flux (even if you use no-clean type fluxes, cleaning residue of flux is recommended); or Washing our Products by using water or water-soluble cleaning agents for cleaning residue after soldering
 - Use of the Products in places subject to dew condensation
- The Products are not subject to radiation-proof design.
- Please verify and confirm characteristics of the final or mounted products in using the Products.
- In particular, if a transient load (a large amount of load applied in a short period of time, such as pulse. is applied, confirmation of performance characteristics after on-board mounting is strongly recommended. Avoid applying power exceeding normal rated power; exceeding the power rating under steady-state loading condition may negatively affect product performance and reliability.
- De-rate Power Dissipation (Pd) depending on Ambient temperature (Ta). When used in sealed area, confirm the actual ambient temperature.
- Confirm that operation temperature is within the specified range described in the product specification.
- ROHM shall not be in any way responsible or liable for failure induced under deviant condition from what is defined in this document.

Precaution for Mounting / Circuit board design

- When a highly active halogenous (chlorine, bromine, etc.) flux is used, the residue of flux may negatively affect product performance and reliability.
- In principle, the reflow soldering method must be used; if flow soldering method is preferred, please consult with the ROHM representative in advance.

For details, please refer to ROHM Mounting specification

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This Product is electrostatic sensitive product, which may be damaged due to electrostatic discharge. Please take proper caution in your manufacturing process and storage so that voltage exceeding the Products maximum rating will not be applied to Products. Please take special care under dry condition (e.g. Grounding of human body / equipment / solder iron, isolation from charged objects, setting of ionizer, friction prevention and temperature / humidity control).

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 - [b] the temperature or humidity exceeds those recommended by ROHM
 - [c] the Products are exposed to direct sunshine or condensation
 - [d] the Products are exposed to high Electrostatic
2. Even under ROHM recommended storage condition, solderability of products out of recommended storage time period may be degraded. It is strongly recommended to confirm solderability before using Products of which storage time is exceeding the recommended storage time period.
3. Store / transport cartons in the correct direction, which is indicated on a carton with a symbol. Otherwise bent leads may occur due to excessive stress applied when dropping of a carton.
4. Use Products within the specified time after opening a humidity barrier bag. Baking is required before using Products of which storage time is exceeding the recommended storage time period.

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